TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

## TC74VHCT74AF,TC74VHCT74AFN,TC74VHCT74AFT

## Dual D-Type Flip-Flop with Preset and Clear

The TC74VHCT74 is an advanced high speed CMOS D-FLIP FLOP fabricated with silicon gate C<sup>2</sup>MOS technology. It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

The signal level applied to the D INPUT is transferred to Q OUTPUT during the positive going transition of the CK pulse.

 $\overline{CLR}$  and  $\overline{PR}$  are independent of the CK and are accomplished by setting the appropriate input low.

The input voltage are compatible with TTL output voltage. This device may be used as a level converter for interfacing  $3.3\ V$  to  $5\ V$  system.

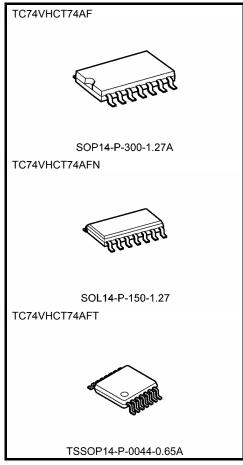
Input protection and output circuit ensure that 0 to 5.5 V can be applied to the input and output  $^{\rm (Note)}$  pins without regard to the supply voltage. These structure prevents device destruction due to mismatched supply and input/output voltages such as battery back up, hot board insertion, etc.

Note:  $V_{CC} = 0 V$ 

#### **Features**

- High speed:  $f_{max} = 160 \text{ MHz}$  (typ.) at  $V_{CC} = 5 \text{ V}$
- Low power dissipation:  $I_{CC} = 2 \mu A \text{ (max)}$  at  $T_{a} = 25 \text{°C}$
- Compatible with TTL outputs:  $V_{IL} = 0.8 \text{ V (max)}$   $V_{IH} = 2.0 \text{ V (min)}$
- Power down protection is provided on all inputs and outputs
- Balanced propagation delays:  $t_{pLH} \simeq t_{pHL}$
- Pin and function compatible with the 74 series (74AC/HC/F/ALS/LS etc.) 74 type.

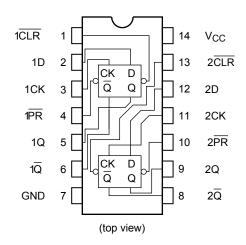
Note: The JEDEC SOP (FN) is not available in Japan.



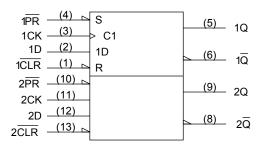
Weight

SOP14-P-300-1.27A : 0.18 g (typ.) SOL14-P-150-1.27 : 0.12 g (typ.) TSSOP14-P-0044-0.65A : 0.06 g (typ.)

#### **Pin Assignment**



### **IEC Logic Symbol**



#### **Truth Table**

	Inp	uts		Out	puts	Function		
CLR	PR	D	CK	Q	Q	FullClion		
L	Н	Χ	Х	L	Н	Clear		
Н	L	Х	Х	Н	L	Preset		
L	L	Х	Х	Н	Н	_		
Н	Н	L		L	Н	_		
Н	Н	Н		Н	L	_		
Н	Н	Х	$\Box$	Qn	$\overline{Q}_n$	No Change		

X: Don't care

### **Absolute Maximum Ratings (Note 1)**

Characteristics	Symbol	Rating	Unit	
Supply voltage range	$V_{CC}$	−0.5 to 7.0	V	
DC input voltage	V <sub>IN</sub>	-0.5 to 7.0	V	
DC output voltage	V	-0.5 to 7.0 (Note 2)	V	
DC output voltage	Vout	-0.5 to V <sub>CC</sub> + 0.5 (Note 3)	V	
Input diode current	I <sub>IK</sub>	-20	mA	
Output diode current	lok	±20 (Note 4)	mA	
DC output current	Гоит	±25	mA	
DC V <sub>CC</sub> /ground current	Icc	±50	mA	
Power dissipation	P <sub>D</sub>	180	mW	
Storage temperature	T <sub>stg</sub>	-65 to 150	°C	

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2:  $V_{CC} = 0 V$ 

Note 3: High or low state. IOUT absolute maximum rating must be observed.

Note 4: V<sub>OUT</sub> < GND, V<sub>OUT</sub> > V<sub>CC</sub>



# **Operating Ranges (Note 1)**

Characteristics	Symbol	Rating	Unit
Supply voltage	$V_{CC}$	4.5 to 5.5	V
Input voltage	V <sub>IN</sub>	0 to 5.5	V
Output voltage	Vout	0 to 5.5 (Note 2)	V
Output voltage	VOU1	0 to V <sub>CC</sub> (Note 3)	V
Operating temperature	T <sub>opr</sub>	-40 to 85	°C
Input rise and fall time	dt/dV	0 to 20	ns/V

Note 1: The operating ranges must be maintained to ensure the normal operation of the device.

Unused inputs must be tied to either VCC or GND.

Note 2:  $V_{CC} = 0 V$ 

Note 3: High or low state

### **Electrical Characteristics**

#### **DC Characteristics**

Characteristics	Symbol	Test Condition			Ta = 25°C			Ta = −40 to 85°C		- Unit
Ondracteristics	Gymbol			V <sub>CC</sub> (V)	Min	Тур.	Max	Min	Max	
High-level input voltage	V <sub>IH</sub>	_			2.0	_	_	2.0	_	V
Low-level input voltage	V <sub>IL</sub>	_			_	_	0.8	_	0.8	V
High-level output	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -50 μA	4.5	4.40	4.50	_	4.40	_	V
voltage			I <sub>OH</sub> = -8 mA	4.5	3.94	_	_	3.80	_	V
Low-level output	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 50 μA	4.5	_	0.0	0.1	_	0.1	V
voltage			I <sub>OL</sub> = 8 mA	4.5	_	_	0.36	_	0.44	V
Input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = 5.5 V or GND		0 to 5.5	_	_	±0.1	_	±1.0	μΑ
	Icc	V <sub>IN</sub> = V <sub>CC</sub> or GND		5.5	_	_	2.0	_	20.0	μΑ
Quiescent supply current	Ісст	Per input: V <sub>IN</sub> = 3.4 V Other input: V <sub>CC</sub> or GND		5.5	_	_	1.35	_	1.50	mA
Output leakage current	I <sub>OPD</sub>	V <sub>OUT</sub> = 5.5 V			_	_	0.5	_	5.0	μА

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### Timing Requirements (input: $t_r = t_f = 3 \text{ ns}$ )

Characteristics	Symbol	Test Condition		Ta = 25°C	Ta = -40 to 85°C	Unit
			V <sub>CC</sub> (V)	Limit	Limit	
Minimum pulse width (CK)	t <sub>w (L)</sub>	_	5.0 ± 0.5	5.0	5.0	ns
Minimum pulse width (CLR, PR)	t <sub>w (L)</sub>	_	5.0 ± 0.5	5.0	5.0	ns
Minimum set-up time	ts	_	5.0 ± 0.5	5.0	5.0	ns
Minimum hold time	t <sub>h</sub>	_	$5.0 \pm 0.5$	0.0	0.0	ns
Minimum removal time ( CLR , PR )	t <sub>rem</sub>	_	5.0 ± 0.5	3.5	3.5	ns

### AC Characteristics (input: $t_r = t_f = 3 \text{ ns}$ )

Characteristics	Symbol	Test Condition		Ta = 25°C			Ta = −40 to 85°C		Unit	
	,		V <sub>CC</sub> (V)	C <sub>L</sub> (pF)	Min	Тур.	Max	Min	Max	
Propagation delay	t <sub>pLH</sub>			15	_	5.8	7.8	1.0	9.0	
time $(CK-Q, \overline{Q})$	t <sub>pHL</sub>	_	- 5.0 ± 0.5	50	_	6.3	8.8	1.0	10.0	ns
Propagation delay	t <sub>pLH</sub>			15	_	7.6	10.4	1.0	12.0	
time $(\overline{CLR}, \overline{PR}-Q, \overline{Q})$	t <sub>pHL</sub>	_	$5.0 \pm 0.5$	50	_	8.1	11.4	1.0	13.0	ns
Maximum clock	†		5.0 ± 0.5	15	100	160	_	80	_	MHz
frequency		_		50	80	140	_	65	_	IVIIIZ
Input capacitance	C <sub>IN</sub>		_		_	4	10	_	10	pF
Power dissipation capacitance	C <sub>PD</sub>			(Note)	_	24	_	_	_	pF

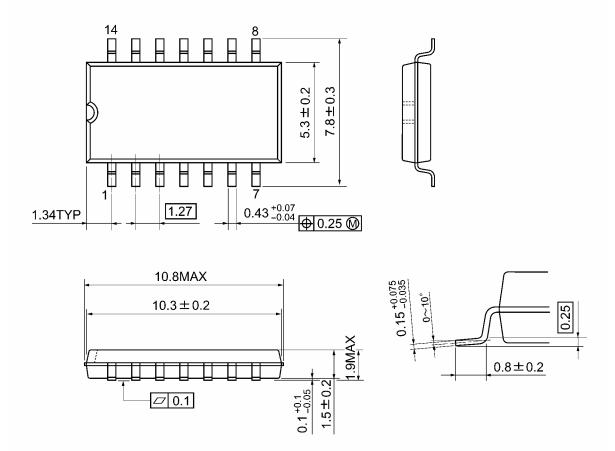
Note: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

$$I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/2 (per F/F)$$

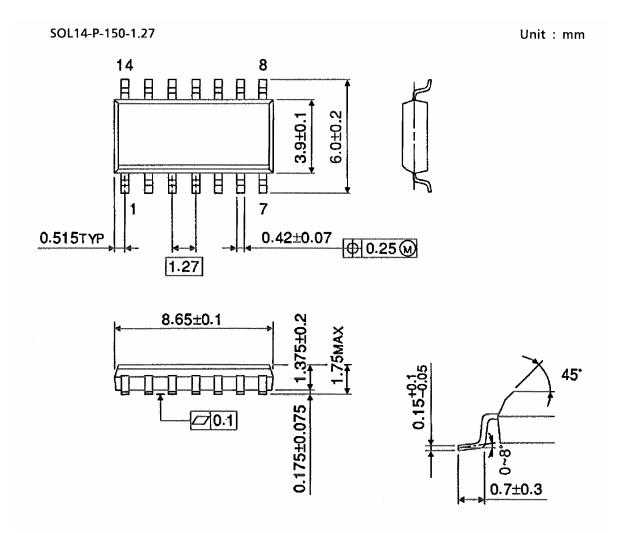
# **Package Dimensions**

SOP14-P-300-1.27A Unit: mm



Weight: 0.18 g (typ.)

# **Package Dimensions (Note)**



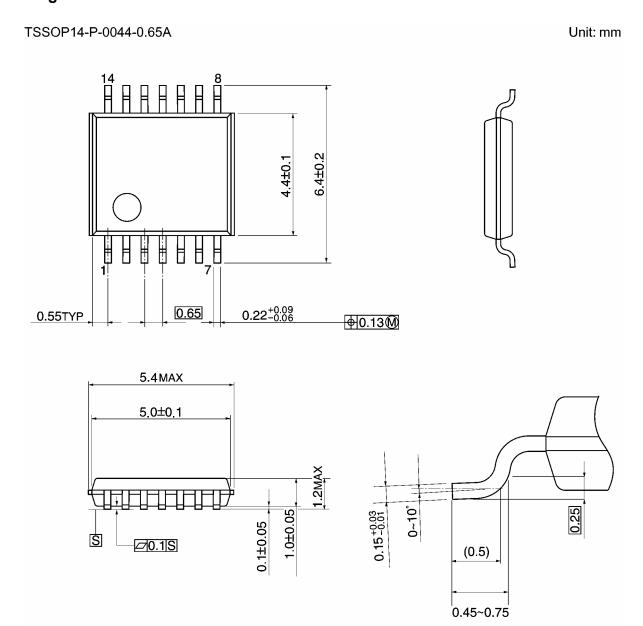
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Note: This package is not available in Japan.

Weight: 0.12 g (typ.)



# **Package Dimensions**



Weight: 0.06 g (typ.)

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20070701-EN GENERAL

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